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FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Attorney Docket No.: W&B-INF-860 Appl. No. O9/977787 Applicant UDO HARTMANN			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Filing Date October 15, 2001 Group Art Unit 2133			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
104	Α	6,195,771 B1	02/01	Tanabe et al.	-		
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
M		Tadahiko Sugibayashi et al.: "A Distributive Serial Multi-Bit Parallel Test Scheme for Large Capacity DRAMs", IEICE Trans. Electron., Vol. E77-C, No. 8, August 1994, pp. 1323-1327;					
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